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| <b>Search Notes</b><br> | <b>Application/Control No.</b><br>10593978 | <b>Applicant(s)/Patent Under Reexamination</b><br>YOSHINO ET AL. |
|  | <b>Examiner</b><br>Desai, Naishadh N       | <b>Art Unit</b><br>2834  |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |            |          |
|---|------------|----------|
| Search Notes  | Date       | Examiner |
| PLUS search   | 12/28/2007 | NND      |
| IDS, INV searches with several backward and forward citations | 12/28/2007 | NND      |
| KPO and JPO NPL considered                                    | 12/28/2007 | NND      |
| Searched 310/254.ccls with keywords                           | 12/28/2007 | NND      |
| Consulted examiner Hanh Nguyen for searches in 310            | 12/28/2007 | NND      |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |